



April 2005

QSB363

Subminiature Plastic Silicon Infrared Phototransistor

Features

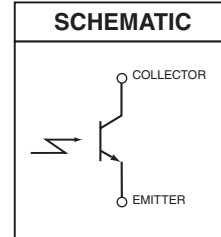
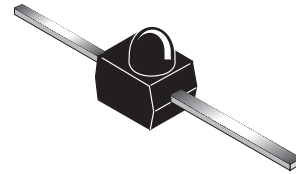
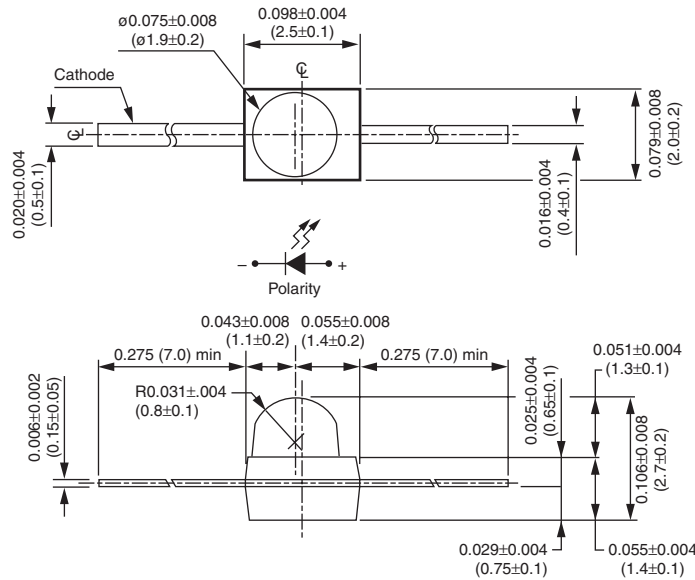
- NPN Silicon Phototransistor
- T-3/4 (2mm) Surface Mount Package
- Medium Wide Beam Angle, 24°
- Black Plastic Package
- Matched Emitters: QEB363 or QEB373

- Daylight Filter
- Tape & Reel Option (See Tape & Reel Specifications)
- Lead Form Options: Gullwing, Yoke, Z-Bend

Description

The QSB363 is a silicon phototransistor encapsulated in a black infrared transparent T-3/4 package.

Package Dimensions



NOTES:

1. Dimensions are in inches (mm).
2. Tolerance of ± 0.010 (.25) on all non nominal dimensions unless otherwise specified.

QSB363 Subminiature Plastic Silicon Infrared Phototransistor

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Operating Temperature	T_{OPR}	-25 to +85	$^\circ\text{C}$
Storage Temperature	T_{STG}	-40 to +85	$^\circ\text{C}$
Soldering Temperature (Iron) ^(2,3,4)	T_{SOL}	260	$^\circ\text{C}$
Soldering Temperature (Flow) ^(2,3)	T_{SOL}	260	$^\circ\text{C}$
Collector Emitter Voltage	V_{CEO}	30	V
Emitter Collector Voltage	V_{ECO}	5	V
Power Dissipation ⁽¹⁾	P_C	75	mW

Notes

1. Derate power dissipation linearly 1.33 mW/ $^\circ\text{C}$ above 25 $^\circ\text{C}$.
2. RMA flux is recommended.
3. Methanol or isopropyl alcohols are recommended as cleaning agents.
4. Pulse conditions: $t_p = 100 \mu\text{s}$, $T = 10 \text{ ms}$.
5. $D = 940 \text{ nm}$, GaAs.

Electrical/Optical Characteristics ($T_A = 25^\circ\text{C}$)

Parameters	Test Conditions	Symbol	Min.	Typ.	Max	Units
Peak Sensitivity Wavelength		λ_P	—	940	—	nm
Reception Angle		θ	—	± 12	—	
Collector Dark Current	$V_{CE} = 20\text{V}$, $E_e = 0\text{mW/cm}^2$	I_{CEO}	—	—	100	nA
Collector-Emitter Breakdown Voltage	$I_C = 100 \mu\text{A}$, $E_e = 0\text{mW/cm}^2$	BV_{CEO}	30	—	—	V
Emitter-Collector Breakdown Voltage	$I_E = 100 \mu\text{A}$, $E_e = 0\text{mW/cm}^2$	BV_{ECO}	5	—	—	V
On-State Collector Current	$V_{CE} = 5\text{V}$ $E_e = 0.5 \text{ mW/cm}^2$	$I_{C(on)}$	1.0	1.5	—	mA
Collector-Emitter Saturation Voltage	$I_C = 2 \text{ mA}$ $E_e = 1 \text{ mW/cm}^2$	$V_{CE(SAT)}$	—	—	0.4	V
Rise Time	$V_{CE} = 5 \text{ V}$, $I_C = 1 \text{ mA}$	t_r	—	15	—	μs
Fall Time	$R_L = 1000\Omega$	t_f	—	15	—	μs

Typical Performance Curves

Fig. 1 Collector Power Dissipation vs. Ambient Temperature

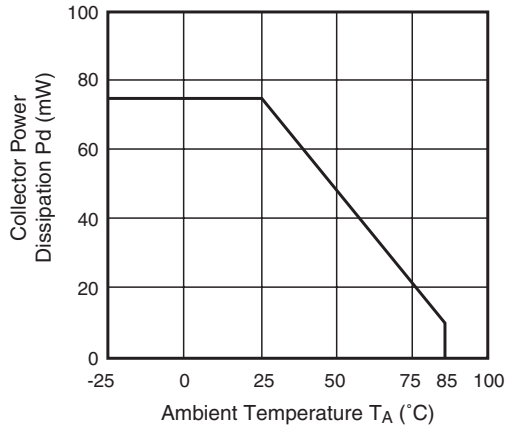


Fig. 2 Spectral Sensitivity

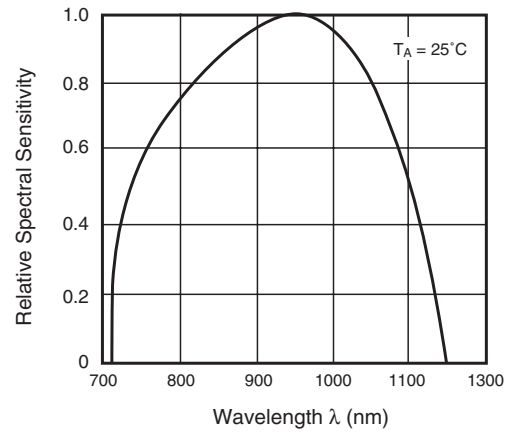


Fig. 3 Relative Collector Current vs. Ambient Temperature

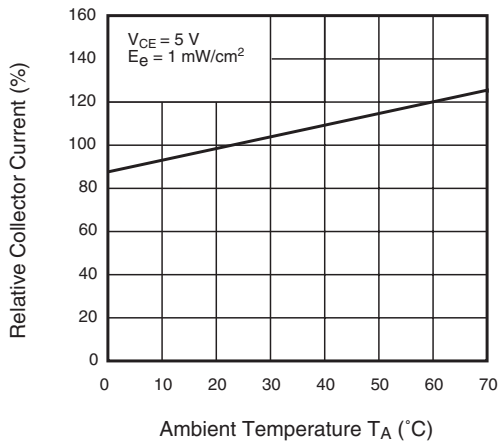


Fig. 4 Collector Current vs. Irradiance

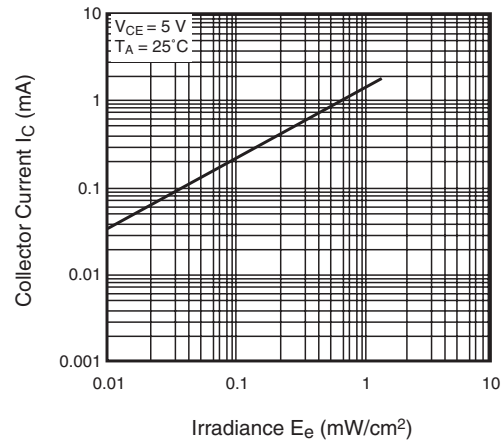


Fig. 5 Collector Dark Current vs. Ambient Temperature

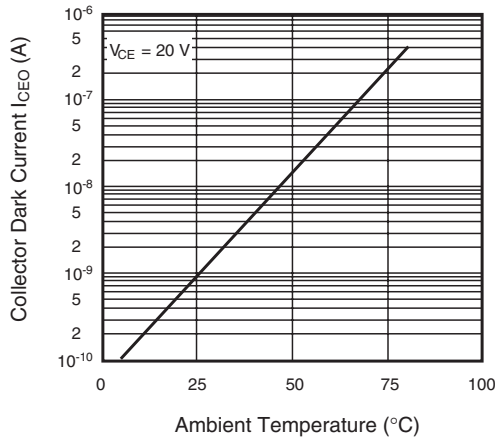
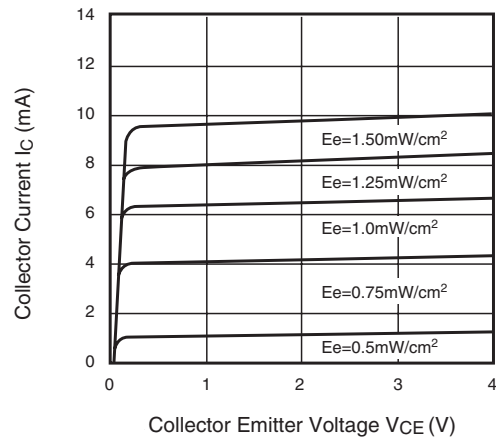


Fig. 6 Collector Current vs. Collector Emitter Voltage

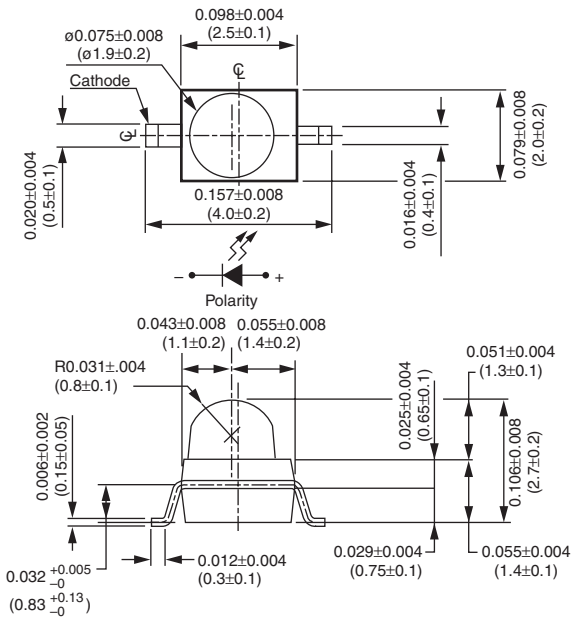


Package Dimensions

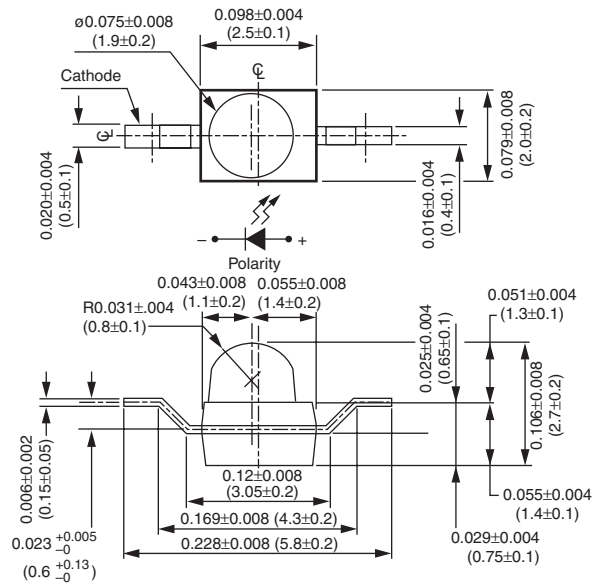
Features

- Three lead forming options: Gull Wing, Yoke and Z-Bend
- Compatible with automatic placement equipment
- Supplied on tape and reel or in bulk packaging
- Compatible with vapor phase reflow solder processes

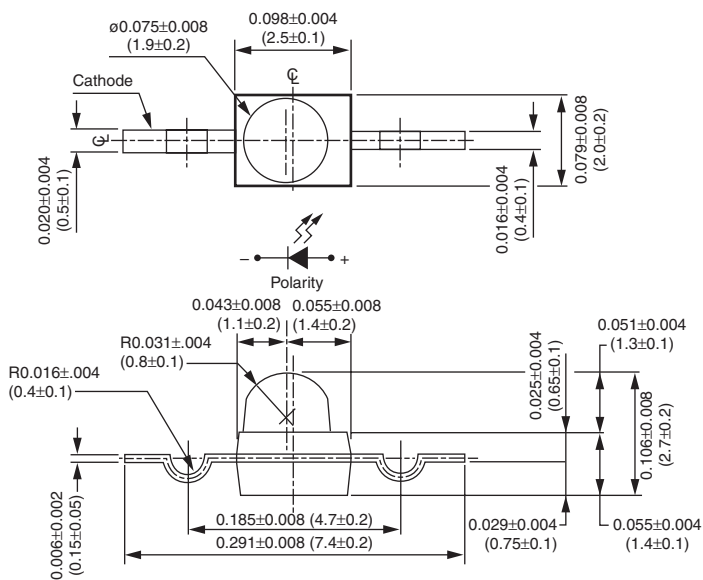
Gull Wing Lead Configuration



Z-Bend Lead Configuration



Yoke Lead Configuration



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EnSigna™	i-Lo™	MSXPro™	Quiet Series™	TINYOPTO™
FACT™	ImpliedDisconnect™	OCX™	RapidConfigure™	TruTranslation™
FACT Quiet Series™		OCXPro™	RapidConnect™	UHC™
Across the board. Around the world.™		OPTOLOGIC®	µSerDes™	UltraFET®
The Power Franchise®		OPTOPLANAR™	SILENT SWITCHER®	UniFET™
Programmable Active Droop™		PACMAN™	SMART START™	VCX™

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